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Biomimetic subwavelength antireflective gratings on GaAs

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We have recently developed an inexpensive and scalable bottom-up approach for fabricating moth-eye antireflective coatings on GaAs substrates. Monolayer, non-close-packed silica colloidal crystals are created on crystalline GaAs wafers by a spin-coating-based single-layer reduction technique. These colloidal monolayers can be used as etching masks during a BCl3 dry-etch process to generate subwavelength-structured antireflective gratings directly on GaAs substrates. The gratings exhibit excellent broadband antireflective properties, and the specular reflection matches with the theoretical prediction using a rigorous coupled-wave analysis model. These bioinspired antireflection coatings have important technological applications ranging from efficient solar cells to IR detectors. © 2008 Optical Society of America

Gallium arsenide (GaAs) is a technologically important semiconductor that has been widely used in optoelectronics, such as vertical cavity surface-emitting lasers [1], near-IR photodetectors [2], and highly efficient concentrator solar cells [3–5]. However, owing to the high refractive index (RI) of GaAs (n_{GaAs} > 3.6 for visible wavelengths), more than 30% of incident light is reflected back from the substrate surface. This greatly reduces the efficiency of GaAs-based optoelectronic devices. To suppress the unwanted reflective losses, vacuum-deposited multilayer dielectric (e.g., MgF2/ZnS) antireflection coatings (ARCs) have been developed [6,7]. Unfortunately, these multilayer ARCs are expensive to fabricate owing to the stringent requirement of high vacuum, material selection, and layer thickness control. Additionally, thermal-mismatch-induced lamination and material diffusion of the multilayer ARCs limit the device performance at high power densities [3].

Inspired by the broadband antireflection of microstructured corneas of moths, which consist of non-close-packed arrays of sub-300 nm nipples [8], subwavelength antireflective structures have been extensively exploited [9–17]. These structures can reduce reflection over a wider range of wavelengths and exhibit much improved thermal stability than conventional multilayer ARCs. However, scalable production of subwavelength ARCs is not a trivial task for the current top-down nanolithography technologies (e.g., electron-beam lithography and interference lithography) [11,13]. Bottom-up colloidal lithography, which uses self-assembled colloidal crystals as deposition or etching masks to pattern periodic nanostructures [18,19], provides a much simpler and inexpensive alternative to nanolithography in creating subwavelength gratings [16,20]. Unfortunately, traditional colloidal assemblies suffer from low throughput, small areas, incompatibility with standard microfabrication, and limited close-packed crystal structures.

We have recently developed an inexpensive and scalable colloidal lithography technology for creating moth-eye antireflective gratings by using monolayer, non-close-packed silica colloidal crystals prepared by a simple spin-coating technique as etching masks [21,22]. However, significant obstacles have been encountered when we employ this nonlithographic technique to GaAs substrates. Only disordered colloidal monolayers can be assembled on GaAs by spin coating. This greatly reduces the uniformity and reproducibility of the antireflective performance of templated ARCs. Here we report a generalized single-layer reduction (SLD) technique that enables reproducible production of monolayer colloidal crystals on a variety of substrates that otherwise lead to the formation of disordered crystals by the traditional spin-coating approach [23,24]. We also demonstrate the scalable production of broadband ARCs on crystalline GaAs substrates, and their antireflective properties are characterized by both experimental measurements and theoretical simulation.

Figure 1(a) shows a typical scanning electron microscope (SEM) image of a colloidal monolayer con-
sisting of 320 nm silica spheres prepared on a crystalline GaAs substrate [N-type, (100), University Wafer] by the standard spin-coating process [23,24]. The particles are completely disordered as confirmed by the rings in the Fourier transform of the SEM image. Contrary to the direct formation of colloidal monolayers by spin coating, where the substrate plays a crucial role in determining the resulting crystalline quality [23,24], double-layer colloidal crystals are firstly assembled in SLD. Figure 1(b) shows a double-layer colloidal crystal prepared by spin-coating colloidal silica suspensions (20 vol. % in non-volatile ethoxylated trimethylolpropane triacrylate monomer) at 8000 rpm for 90 s. The non-close-packed hexagonal arrangement for both the top- and bottom-layer particles is clearly evident. After removing the top-layer particles by sweeping using a clean-room Q-tip under flowing water, crystalline colloidal monolayers with non-close-packed structure are formed as shown in Fig. 1(c). The distinctive six-arm Bragg diffraction star formed on the 2 in. (5.08 cm) GaAs wafer [inset of Fig. 1(c)] indicates the hexagonal ordering is over the whole wafer surface [24,25]. The interparticle distance of the non-close-packed colloidal crystal is determined to be 1.40*D, where D is the diameter of silica spheres, by the first peak of the pair-correlation function [PCF, Fig. 1(d)], g(r), which is calculated as g(r)=1/(\langle \rho \rangle)dn(r,r+dr)/da(r,r+dr), where dn counts the number of spheres that lie within a spherical shell, dr, of radius r from an arbitrary origin; da=2\pi dr for a particular radial distance r; and \langle \rho \rangle is the average particle number density. Figure 1(d) also shows the positions of the oscillating PCF peaks with those obtained from a perfect hexagonal lattice with \sqrt{2}D interparticle distance. Preliminary results show the SLD technology can be easily and reproducibly applied to other important substrates, such as Ni, Cr, glass, and poly(methyl methacrylate). Only disordered monolayers are formed on these substrates by the traditional spin-coating technique [24].

The periodically arranged silica particles can then be used as etching masks during a BCl3 reactive ion etch (RIE) process operating at 7.5 mTorr chamber pressure, 20 SCCM (SCCM denotes cubic centimeters per minute at standard temperature and pressure) BCl3, RIE=100 W, and inductively coupled plasma (ICP)=300 W on a Unaxis Shuttlelock reactive ion etcher to generate arrays of cone shaped nanopillars. Figures 2(a) and 2(b) show the templated GaAs structures after 9.5 min RIE and removing templating silica particles by 2% hydrofluoric acid wash. Interestingly, we observe the formation of mushroom-like microstructures. The “stems” of the mushrooms are cone-shaped and are caused by the isotropic etching of GaAs by reactive chlorine ions. The polymer wetting layer between the templating silica spheres and the substrate [26], which protects the GaAs surface immediately under the particles from being etched, causes the formation of the flat “caps” of the mushrooms. This unusual microstructure has been used to develop superoleophobic surface [27], though it is not easily available by conventional top-down and bottom-up techniques. Longer dry etching leads to sharper conical stems and smaller caps as revealed by the SEM image of a 12 min etched sample in Fig. 2(c). The residual caps can finally be removed by a brief ultrasonication in acetone, resulting in the formation of conical GaAs gratings as shown in Fig. 2(d). The preservation of the long-range hexagonal ordering and the interparticle distance of the original silica colloidal monolayer throughout the templating process are clearly evident by comparing the SEM images of Figs. 1 and 2.

The specular reflectivity of the templated subwavelength gratings are evaluated using visible- and near-IR reflectivity measurement at normal incidence by using an Ocean Optics HR4000 spectrometer. The solid curves in Fig. 3 show the measured reflection from a bare GaAs wafer and the nanocone grating as shown in Fig. 2(d). The wafer exhibits >30% reflectivity, while much reduced reflection (<3%) is obtained for the templated subwavelength grating. Importantly, the resulting moth-eye ARCs on GaAs are broadband, exhibiting consistent low reflection over both visible and near-IR wavelengths.

The optical measurement is complemented by theoretical simulation using a rigorous coupled-wave analysis (RCWA) model [28]. A conical profile is used to simulate the templated nipples as shown in Fig. 2(d). We divide the cone array into 100 horizontal circular layers. The intercone distance is defined as \sqrt{2}D by the PCF calculation shown in Fig. 1(d). We can
calculate the fraction of GaAs in each layer as $f(z^*) = \pi(r^*)^2/\sqrt{3}D^2$, where $z^*$ and $r^*$ are the $z$ coordinate and the bottom radius of the cone, respectively. Based on the effective medium theory, the effective RI $n(z^*)$ of the layer at height $z^*$ can be approximated by $n(z^*) = [f(z^*)n_{GaAs} + (1-f(z^*))n_{air}]^{1/2}$, where $q = 2/3$ [8, 29]. We can then calculate the total reflectance of the layered system by solving Maxwell’s equation to express the electromagnetic (EM) field in each layer and matching EM boundary conditions between neighboring layers. The complex RI of GaAs is used to calculate the resulting reflectance [30].

The curves with circles in Fig. 3 show the simulated reflection from a flat GaAs wafer and an array of conical nipples templated from 320 nm silica spheres. The calculated spectrum for the featureless substrate has the same shape as the experimental result. The simulated reflection from the subwavelength nanocone array also agrees reasonably well with the experimental spectrum. The excellent broadband antireflection properties of the templated conical gratings can be understood by mapping the broadband antireflection properties of the templated substrate has the same shape as the experimental reflection from a flat GaAs wafer and an array of neighboring layers. The complex RI of GaAs is used to calculate the resulting reflectance [30].

In summary, we have developed a nonlithographic technology for creating moth-eye antireflection coatings on GaAs substrates. The technique is scalable and compatible with standard microfabrication, promising for developing more economic, efficient, and reliable GaAs-based optoelectronic devices.

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References


Fig. 4. Change of the calculated effective refractive index at $\lambda = 700$ nm from the wafer surface (depth=0) to the bottom of templated GaAs nanocones with 320 nm height. The dotted line indicates the refractive index of bulk GaAs at the same wavelength.